## COM analysis of contributed

 C2M channels - towards a 200 Gb/s per lane AUI proposalAdee Ran, Cisco

## Intro

- For a C2M baseline proposal we need to agree on channels and endpoint assumptions
- Effects on the architecture should also be considered
- This presentation addresses
- What channels are feasible
- What error statistics can be expected
- What would it take


## Previous work

- Several sets of AUI channels have been contributed
- akinwale 3df 01 2209, akinwale 3df 02 2209, akinwale 3df 032209 (chip to module, range of losses)
- mellitz 3df 022207 (chip to chip)
- rabinovich 3df 01 2209, rabinovich 3df 012209 (chip to module)
(+some earlier contributions)
- mli 3df 02a 220316 proposes die termination and package model
- benartsi 3df 01b 2207 proposes model and parameters for largescale switch package
- kareti 3df 01a 2207 suggests large-scale switch applications may need $36-38 \mathrm{~dB}$ die to die


## Goals of this presentation

- Propose a set of COM parameters (and a configuration spreadsheet) for $200 \mathrm{~Gb} / \mathrm{s}$ AUI application
- Propose a loss budget for C2M
- Highlight effects on the 802.3dj architecture beyond electrical specifications


## Method

1. Define channel construction for C 2 M simulation
2. Identify the key COM parameters for a selected subset of C2M channels
3. Propose a set of values for these parameters (operating point)
4. Examine sensitivity around the working point
5. Run COM on the full set of channels

## Channel construction



## Channel set for operating point selection

| Channel <br> $\#$ | Source | File/folder Name(s) | IL [dB] @ 56.125 GHz <br> (Thru, BGA to BGA) | IL [dB] including <br> packages (min, max) |
| :--- | :--- | :--- | :--- | :--- |
| $1-3$ | rabinovich_3df_02_2209 | Rabinovich_C2M_200G_Paral_*mil_092122 <br> $[19,67,93]$ | $12.3,13.3,13.4$ | $21.3-26.4$ |
| $4-5$ | mellitz_3df_02_2207 | TA_6002_6003 <br> TA_600_6003_tp0_tp5 | 13.9 | $22.9-37.3$ |
| $6-12$ | akinwale_3df_02_2209 | C2M_PCB_93ohms_*dB_202208016_v2 <br> $[10,15,20,22,24,26,28]$ | $8.8,13,18.1,20.6,22.3$, <br> $24.9,26.6$ | $17.8-39.9$ |

## $15 \mathrm{~mm} / 30 \mathrm{~mm}$ host packages and module package add $9 / 13 \mathrm{~dB}$ to each channel

(without die models)

## Key parameters

- Initial analysis identified the following parameters as having a large effect on COM:
- $\eta_{0}$ (receiver input noise spectral density)
- $T_{r}$ (transmitter bandwidth)
- $\mathrm{f}_{\mathrm{r}}$ (receiver bandwidth)
- Max b(1)
- DER
(other parameters that may also have a large effect, but are considered hard to change, were not included in the analysis)
- A set of values for these parameters, which makes two challenging channels have $C O M \approx 3 \mathrm{~dB}$, was defined as the "operating point"
- Channel \# 5 ( 37.3 dB die-to-die)
- Channel \#10 (35.3 dB die-to-die)


## Proposed values for key parameters

| Parameter | In 100GBASE-CR (Clause 162) | In 100GAUl-1 C2C <br> (Annex 120F) | Proposed Value for 200GAUI | Rationale |
| :---: | :---: | :---: | :---: | :---: |
| $\mathrm{n}_{0}\left[\mathrm{~V}^{2} / \mathrm{GHz}\right]$ | $9 \mathrm{e}-9$ | 2e-8 | 4e-9 | About the same RMS with doubled bandwidth. <br> Related to package xtalk, thermal and device noise; Challenging but achievable |
| $\mathrm{T}_{\mathrm{r}}$ [ps] | 7.5 | 7.5 | 6 | Silicon switching speed does not scale; improved only by process |
| $\mathrm{f}_{\mathrm{r}}$ | $0.75 * \mathrm{f}_{\mathrm{b}}(\approx 40 \mathrm{GHz}$ ) | $0.75 * \mathrm{f}_{\mathrm{b}}(\approx 40 \mathrm{GHz})$ | 0.55* $\mathrm{f}_{\mathrm{b}}(\approx 58 \mathrm{GHz}$ ) | High bandwidth is challenging; lower BW improves COM results |
| $\mathrm{bb}_{\max }(1)$ | 0.85 | 0.65 | 1 | High value required for high loss channels; error propagation can be addressed |
| SNR ${ }_{\text {TX }}$ | 32.5 | 33 | 32.5 | Increasing would burden design and has diminishing return on high loss channels |
| DER ${ }_{0}$ | $1 \mathrm{e}-4$ | $1 \mathrm{e}-5$ | 1e-4 | RS544 with uncorrelated errors needs DER=4e-4 for FLR=1e-12 BER budgeting with a low portion for AUIs does not seem feasible (may be split between 2 AUIs) |
| $\mathrm{N}_{\mathrm{b}}$ | 12 | 6 | 24 | Scale with UI |
| $\mathrm{N}_{\mathrm{f}}$ | 40 | 0 | 80 | Scale with UI |
| Tx FFE length | 5 (3 pre) | 5 (3 pre) | 6 (4 pre) | Compensate better for pulse rise time; relatively cheap to implement |

Note: full proposed parameter table in the final slide

## COM results at operating point



## Implications

- DERO $=1 \mathrm{e}-4$ is close to the full RS544 correction capability
- We need to enable error correction for the electrical segment alone
- Operating with 1e-5 may be possible with lower loss channels - in these cases it may be possible to bypass error correction
- Possible solution: Flexible segmented / concatenated architecture
- Large value of $b_{\max }(1) \Rightarrow$ correlated errors are possible
- If bit muxing is used, the actual BER will need to be much lower than $D_{0} / 2$ to get equivalent FEC performance
- Possible solution: Symbol muxing PMA
- Tx FFE values have a large variation over the channels considered (see backup)
- This is for a specific reference receiver; real receivers may vary further
- Tx parameters may need to be optimized per AUI channel/receiver
- Module output too
- Possible solution: Link training over the AUI segment


## Effect of $\eta_{0}$

$\eta_{0}\left[\mathrm{~V}^{2} / \mathrm{GHz}\right]$ sweep from 1e-9 to 9e-9 in 1e-9 step


## Effect of $T_{r}$

## $\mathrm{T}_{\mathrm{r}}$ [ps] sweep from 3.5 to 7.5 in 0.5 step



## Effect of $f_{r}$

$f_{r} / f_{b}$ sweep from 0.4 to 0.75 in 0.05 step


## Effect of $\mathrm{bb}_{\text {max }}(1)$

## $\mathrm{bb}_{\max }(1)$ sweep from 0.5 to 1 in 0.1 step



## Effect of SNR $_{T X}$

$\mathrm{SNR}_{\mathrm{TX}}$ sweep from 29 to 34 in 0.5 step


## Effect of DER ${ }_{0}$

$D E R_{0}$ sweep from 1e-5 to 1e-3, 4 steps per decade


## Future work

- Fine-tune parameters with more channels
- Analyze the effect of bit/symbol muxing on FLR with given DER
- Consider electrical specification method for C2M
- What should be similar to C2C / backplane
- What should be different
- Address functional aspects
- Symbol muxing
- Link training on AUIs within a segmented link (optical/electrical)


## Summary

- Feasibility of contributed C2M channels with die-to-die IL from 18 dB to 37 dB has been demonstrated by COM analysis
- An operating point for key parameters is proposed
- Implications beyond electrical specifications must be considered
- FEC scheme
- Symbol muxing
- Link training on AUI


## Proposed COM spreadsheet (operating point)

| Table 93A-1 parameters |  |  |  |
| :---: | :---: | :---: | :---: |
| Parameter | Setting | Units | Information |
| f_b | 106.25 | GBd |  |
| $f$ min | 0.02 | GHz |  |
| Delta_f | 0.02 | GHz |  |
| C_d | [40 90 110; 40900110$]^{* 1 e-6}$ | nF | [TX RX] |
| L_S | [0.13 0.15 0.14; 0.13 0.15 0.14] | nH | [ TXRX] |
| C_b | [0.3e-4 0.3e-4] | nF | [TXRX] |
| 2_p select | [12] |  | [test cases to run] |
| $z \_p(T X)$ | [15 30; 22; 0.18 0.18; 0.5 0.5] | mm | [test cases] |
| 2_p ${ }^{\text {dexT }}$ ) | [ $66 ; 0.50 .5 ; 0.180 .18 ; 0.40 .4$ ] | mm | [test cases] |
| $z_{\sim} \quad$ p (FEXT) | [15 30; 22; 0.180.18; 0.5 0.5] | mm | [test cases] |
| $\underline{Z} \_$p $(\mathrm{R})$ | [ $66 ; 0.50 .5 ; 0.180 .18 ; 0.40 .4]$ | mm | [test cases] |
| C_p | [8e-6 0] | nF | [TX RX] |
| R_0 | 50 | Ohm |  |
| R_d | [50 50] | Ohm | [TX RX] |
| A_v | 0.413 | v |  |
| A_fe | 0.413 | v |  |
| A_ne | 0.608 | v |  |
| L | 4 |  |  |
| M | 32 | Samp/U |  |
| samples_for_C2M | 100 | Samp/uI |  |
| T_O | 50 | mU |  |
| AC_CM_RMS | 0 | v | [test cases] |
| filter and Eq |  |  |  |
| f_r | 0.55 | *fb |  |
| c(0) | 0.5 |  | min |
| $\mathrm{c}-1)^{\text {a }}$ | [-0.34:0.02:0] |  | [min:step:max] |
| c(-2) | [0:0002:0.14] |  | [min:step:max] |
| $\mathrm{c}(-3)$ | [-0.006:0.02:0] |  | [min:step:max] |
| c(-4) | [0:00.01:0.03] |  | [min:step:max] |
| c(1) | [-0.1:0:002:0] |  | [min:step:max] |
| N_b | 24 | UI |  |
| b_max(1) | 1 |  | As/dffe1 |
| b_max(2..N_b) | 0.3 |  | As/dfe2..N_b |
| b_min(1) | 0.3 |  | As/dffe1 |
| b_min(2..N_b) | -0.15 |  | As/dfe2..N_b |
| g_DC | [-18:1:8] | dB | [min:step:max] |
| $\mathrm{f}_{\text {_ }}$ | 42.5 | GHz |  |
| $\mathrm{f}_{\text {¢ }} \mathrm{p} 1$ | 42.5 | GHz |  |
| ${ }_{\text {f }}$ | 106.25 | GHz |  |
| g_DC_HP | [-3:0:5:0] |  | [min:step:max] |
| $\mathrm{f}_{\text {_ } \mathrm{HP} \text { _PZ }}$ | 0.6 | GHz |  |


| 1/0 control |  |  | Table 93A-3 parameters |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
| DIAGNOSTICS | 1 | logical | Parameter | Setting | Units |
| DISPLAY_WINDOW | 0 | logical | package_tı_gamma0_a1_a2 | [01.33e-3 3.9525e-4] |  |
| CSV_REPORT | 1 | logical | package_tl_tau | 6.420E-03 | ns/mm |
| RESULT_DIR | .\|results \date\}\} | Path | package_Z_c | [9494;9090; 200 200; 70 70] | Ohm |
| SAVE_FIGURES | 0 | logical | ICN \& FOM_ILD parameters |  |  |
| Port Order | [1324] |  | f_v | 0.371 | *Fb |
| RUNTAG | C2M_eval_ |  | f_f | 0.371 | GHz f_r specified in first column |
| COM_CONTRIBUTION | 0 | logical | f_n | 0.371 | GHz |
| Local Search | 2 |  | f_2 | 58.4375 | GHz |
| Operational |  |  | A_ft | 0.600 | v |
| COM Pass threshold | 3 | dB | A_nt | 0.600 | v |
|  |  |  |  |  |  |
| ERL Pass threshold | 7.3 | dB | Histogram_Window_Weight | Gaussian | gaussian. triangle, rectangle |
|  |  |  | sigma_r | 0.02 | sigma in Ul fo or gaus.. Wind |
| DER_0 | 1.00E-04 |  |  |  |  |
| T_r | 6.00E-03 | ns | Table 92-12 parameters |  |  |
| FORCE_TR | 1 | 5 | Parameter | Setting |  |
| PMD_type | C2C |  | board_tı_gamma0_11_a2 | [03.8206e-04 9.5909e-05] |  |
| BREAD_CRUMBS | 0 | logical | board_tI_tau | 0.00579 | ns/mm |
| SAVE_CONFIG2MAT | 1 | logical | board_Z_c | 100 | Ohm |
| PLOT_CM | 0 | logical | 2_bp (TX) | 407 | mm |
| TDR and ERL options |  |  | z_bp ( (EXT) | 407 | mm |
| TDR | 1 | logical | 2_bp (FEXT) | 407 | mm |
| ERL | 1 | logical | $\underline{2}$ _bp (RX) | 407 | mm |
| ERL_ONLY | 0 | logical | C_0 | 0 | nF |
| TR_TDR | 0.01 | ns | C_1 | 0 | nF |
| N | 1200 |  | Include PCB | 0 | logical |
| beta_x | 0 |  |  |  |  |
| rho_x | 0.618 |  |  |  |  |
| fixture delay time | [00] | port1 port2 | different for each test fixture |  |  |
| TDR_W_TXPKG | 0 |  |  |  |  |
| N_bx | 0 | UI |  |  |  |
| Tukey_Window | 1 |  | updated for 802.3dt/dj C2M |  |  |
| Receiver testing |  |  |  |  |  |
| RX_CALBRATION | 0 | logical |  |  |  |
| Sigma BBN step | 5.00--03 | v |  |  |  |
| Noise, jitter |  |  |  |  |  |
| sigma_RJ | 0.01 | UI |  |  |  |
| A_DD | 0.02 | UI |  |  |  |
| eta_0 | 4.00E-09 | V^2/GHz |  |  |  |
| SNR_TX | 32.5 | dB |  |  |  |
| R_LM | 0.95 |  |  |  |  |



## Backup

## All contributed channels at operating point (Color scale: IL D2D)

```
min(COM) per channel_id
    akinwale_3df_2209/100ohms/C2M_PCB_100ohms_11dB_202208016_v2 akinwale_3df_2209/100ohms/C2M_PCB_100ohms_14dB_202208016_v2 akinwale_3df_2209/100ohms/C2M_PCB_100ohms_17dB_202208016_v2 akinwale_3df_2209/100ohms/C2M_PCB_100ohms_20dB_202208016_v2 akinwale_3df_2209/100ohms/C2M_PCB_100ohms_23dB_202208016_v2 akinwale_3df_2209/100ohms/C2M_PCB_100ohms_26dB_202208016_v2 akinwale_3df_2209/85ohms/C2M_PCB_85ohms_12dB_202208016_v2 akinwale_3df_2209/850hms/C2M_PCB_85ohms_15dB_202208016_V2 akinwale_3df_2209/85ohms/C2M_PCB_85ohms_18dB_202208016_v2 akinwale_3df_2209/850hms/C2M_PCB_85ohms_21dB_202208016_V2 akinwale_3df_2209/85ohms/C2M_PCB_85ohms_24dB_202208016_v2 akinwale_3df_2209/93ohms/C2M_PCB_93ohms_10dB_202208016_v2 akinwale_3df_2209/93ohms/C2M_PCB_93ohms_13dB_202208016_v2 akinwale_3df_2209/93ohms/C2M_PCB_93ohms_16dB_202208016_v2 akinwale_3df_2209/93ohms/C2M_PCB_93ohms_19dB_202208016_v2 akinwale_3df_2209/93ohms/C2M_PCB_93ohms_22dB_202208016_v2 akinwale_3df_2209/93ohms/C2M_PCB_93ohms_25dB_202208016_v2 mellitz_3df_02_2207/TA_6002_6003_tp0_tp5 rabinovich_3df_01_2209/rabinovich_C2M_200G_Ortho_93mil_092122
```



## All contributed channels at operating point (Color scale: ICN)



## Tx FFE coefficients



## COM/IL scatter plot

COM_dB vs. IL die-to-die


## COM/ICN scatter plot



